

IMW120R060M1H

CoolSiC™ 1200V SiC Trench MOSFET Silicon Carbide MOSFET

Features

- Very low switching losses
- Threshold-free on state characteristic
- Wide gate-source voltage range
- Benchmark gate threshold voltage, $V_{GS(th)} = 4.5V$
- 0V turn-off gate voltage for easy and simple gate drive
- Fully controllable dV/dt
- Robust body diode for hard commutation
- Temperature independent turn-off switching losses



Benefits

- Efficiency improvement
- Enabling higher frequency
- Increased power density
- Cooling effort reduction
- Reduction of system complexity and cost



Potential applications

- Energy generation
 - Solar string inverter and solar optimizer
- Industrial power supplies
 - Industrial UPS
 - Industrial SMPS
- Infrastructure – Charge
 - Charger



Product validation

Qualified for industrial applications according to the relevant tests of JEDEC 47/20/22

Table 1 Key Performance and Package Parameters

Type	V_{DS}	I_D $T_C = 25^\circ C, R_{th(j-c,max)}$	$R_{DS(on)}$ $T_{vj} = 25^\circ C, I_D = 13A, V_{GS} = 18V$	$T_{vj,max}$	Marking	Package
IMW120R060M1H	1200V	36A	60mΩ	175°C	12M1H060	PG-T0247-3

Table of contents**Table of contents**

Features	1
Benefits	1
Potential applications	1
Product validation	1
Table of contents.....	2
1 Maximum ratings	3
2 Thermal resistances	4
3 Electrical Characteristics	5
3.1 Static characteristics.....	5
3.2 Dynamic characteristics.....	6
3.3 Switching characteristics.....	7
4 Electrical characteristic diagrams	8
5 Package drawing.....	14
6 Test conditions	15
Revision history.....	16

Maximum ratings**1 Maximum ratings**

For optimum lifetime and reliability, Infineon recommends operating conditions that do not exceed 80% of the maximum ratings stated in this datasheet.

Table 2 Maximum ratings

Parameter	Symbol	Value	Unit
Drain-source voltage, $T_{vj} \geq 25^\circ\text{C}$	V_{DSS}	1200	V
DC drain current for $R_{th(j-c,max)}$, limited by T_{vjmax} , $V_{GS} = 18\text{V}$, $T_c = 25^\circ\text{C}$ $T_c = 100^\circ\text{C}$	I_D	36 26	A
Pulsed drain current, t_p limited by T_{vjmax} , $V_{GS} = 18\text{V}$	$I_{D,pulse}^1$	76	A
DC body diode forward current for $R_{th(j-c,max)}$, limited by T_{vjmax} , $V_{GS} = 0\text{V}$ $T_c = 25^\circ\text{C}$ $T_c = 100^\circ\text{C}$	I_{SD}	36 22	A
Pulsed body diode current, t_p limited by T_{vjmax}	$I_{SD,pulse}^1$	76	A
Gate-source voltage ² Max transient voltage, < 1% duty cycle	V_{GS}	-7... 23	V
Recommended turn-on gate voltage	$V_{GS,ON}$	15... 18	
Recommended turn-off gate voltage	$V_{GS,OFF}$	0	
Short-circuit withstand time $V_{DD} = 800\text{V}$, $V_{DS,peak} < 1200\text{V}$, $V_{GS,ON} = 15\text{V}$, $T_{j,start} = 25^\circ\text{C}$	t_{SC}	3	μs
Power dissipation, limited by T_{vjmax} $T_c = 25^\circ\text{C}$ $T_c = 100^\circ\text{C}$	P_{tot}	150 75	W
Virtual junction temperature	T_{vj}	-55... 175	$^\circ\text{C}$
Storage temperature	T_{stg}	-55... 150	$^\circ\text{C}$
Soldering temperature, wave soldering only allowed at leads, 1.6mm (0.063 in.) from case for 10 s	T_{sold}	260	$^\circ\text{C}$
Mounting torque, M3 screw Maximum of mounting processes: 3	M	0.6	Nm

¹ verified by design² **Important note:** The selection of positive and negative gate-source voltages impacts the long-term behavior of the device. The design guidelines described in [Application Note AN2018-09](#) must be considered to ensure sound operation of the device over the planned lifetime.

Thermal resistances

2 Thermal resistances

Table 3

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
MOSFET/body diode thermal resistance, junction – case	$R_{th(j-c)}$		-	0.8	1	K/W
Thermal resistance, junction – ambient	$R_{th(j-a)}$	leaded	-	-	62	K/W

Electrical Characteristics

3 Electrical Characteristics**3.1 Static characteristics****Table 4 Static characteristics (at $T_{vj} = 25^\circ\text{C}$, unless otherwise specified)**

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS} = 18\text{V}, I_D = 13\text{A}, T_{vj} = 25^\circ\text{C}$	-	60	83	$\text{m}\Omega$
		$T_{vj} = 100^\circ\text{C}$	-	76	-	
		$T_{vj} = 175^\circ\text{C}$	-	113	-	
		$V_{GS} = 15\text{V}, I_D = 13\text{A}, T_{vj} = 25^\circ\text{C}$	-	80	106	
Body diode forward voltage	V_{SD}	$V_{GS} = 0\text{V}, I_{SD} = 13\text{A}$	-	4.1	5.2	V
		$T_{vj} = 25^\circ\text{C}$	-	4.0	-	
		$T_{vj} = 100^\circ\text{C}$	-	3.9	-	
		$T_{vj} = 175^\circ\text{C}$	-			
Gate-source threshold voltage	$V_{GS(th)}$	(tested after 1 ms pulse at $V_{GS} = 20\text{V}$)	-			V
		$I_D = 5.6\text{mA}, V_{DS} = V_{GS}$				
		$T_{vj} = 25^\circ\text{C}$	3.5	4.5	5.7	
		$T_{vj} = 175^\circ\text{C}$	-	3.6	-	
Zero gate voltage drain current	I_{DSS}	$V_{GS} = 0\text{V}, V_{DS} = 1200\text{V}$	-	0.6	180	μA
		$T_{vj} = 25^\circ\text{C}$	-	1.9	-	
		$T_{vj} = 175^\circ\text{C}$	-			
Gate-source leakage current	I_{GSS}	$V_{GS} = 23\text{V}, V_{DS} = 0\text{V}$	-	-	100	nA
		$V_{GS} = -7\text{V}, V_{DS} = 0\text{V}$	-	-	-100	
Transconductance	g_{fs}	$V_{DS} = 20\text{V}, I_D = 13\text{A}$	-	7	-	s
Internal gate resistance	$R_{G,int}$	$f = 1\text{MHz}, V_{AC} = 25\text{mV}$	-	6	-	Ω

3.2 Dynamic characteristics

Table 5 Dynamic characteristics (at $T_{vj} = 25^\circ\text{C}$, unless otherwise specified)

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Input capacitance	C_{iss}	$V_{DD} = 800\text{V}, V_{GS} = 0\text{V}, f = 1\text{MHz}, V_{AC} = 25\text{mV}$	-	1060	-	pF
Output capacitance	C_{oss}		-	58	-	
Reverse capacitance	C_{rss}		-	6.5	-	
C_{oss} stored energy	E_{oss}		-	22	-	μJ
Total gate charge	Q_G	$V_{DD} = 800\text{V}, I_D = 13\text{A}, V_{GS} = 0/18\text{V}$, turn-on pulse	-	31	-	nC
Gate to source charge	$Q_{GS,pl}$		-	9	-	
Gate to drain charge	Q_{GD}		-	7	-	

4 Electrical characteristic diagrams

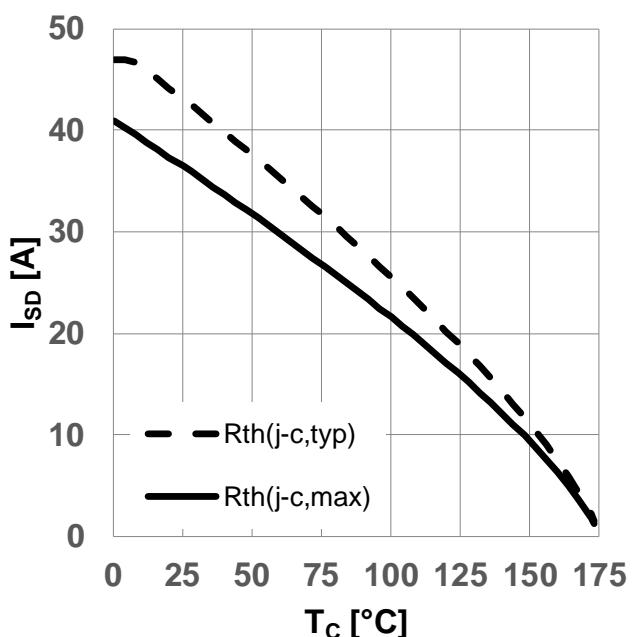
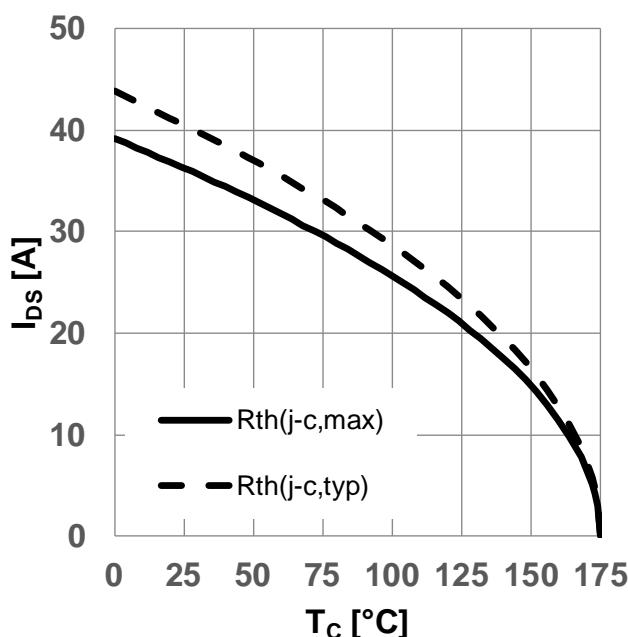
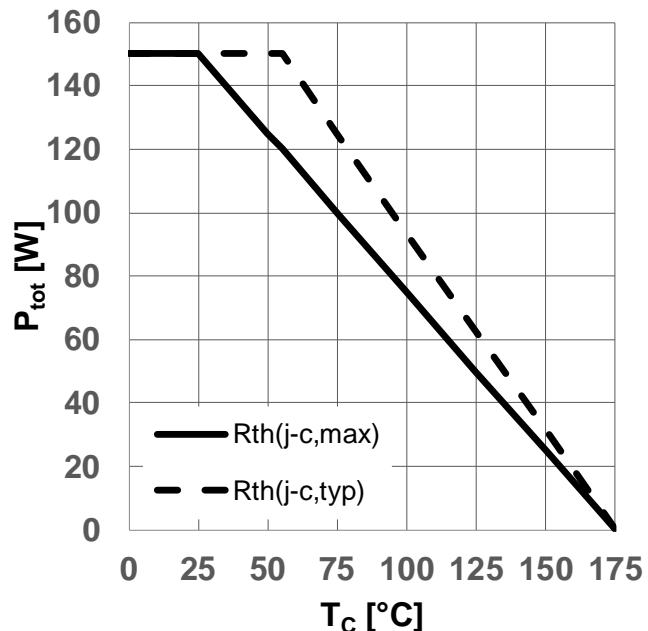
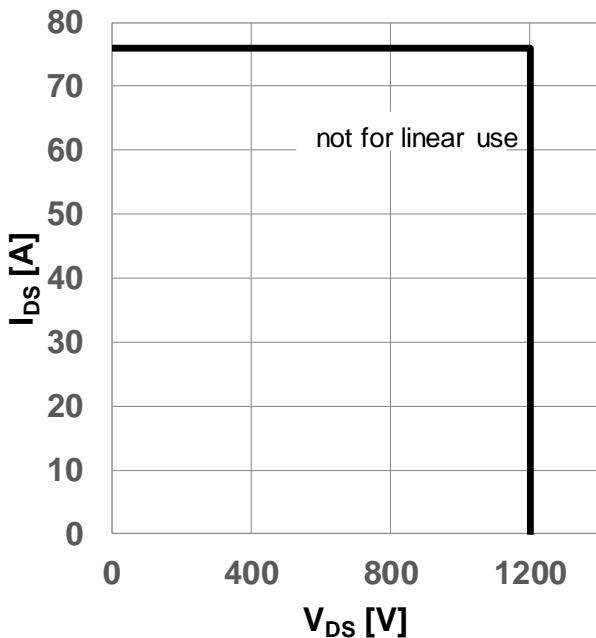


Figure 3 Maximum DC drain to source current as a function of case temperature limited by bond wire
 $(I_{DS} = f(T_c))$

Figure 4 Maximum source to drain current as a function of case temperature limited by bond wire
 $(I_{SD} = f(T_c), V_{GS} = 0\text{V})$

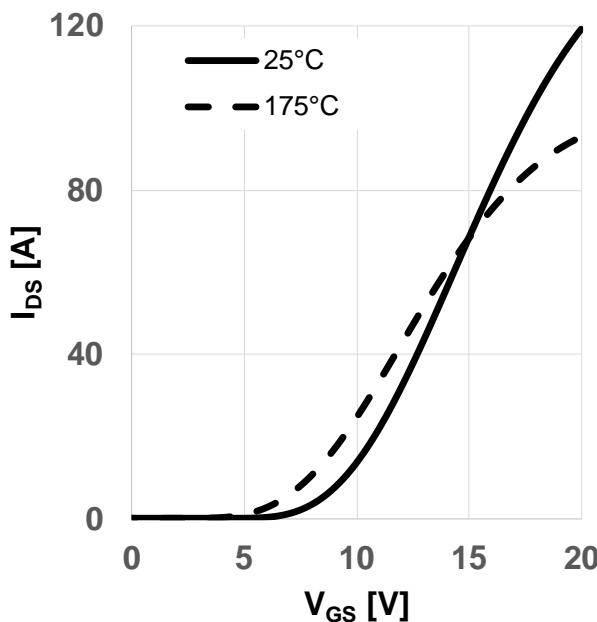


Figure 5 Typical transfer characteristic
 $(I_{DS} = f(V_{GS}), V_{DS} = 20\text{V}, t_p = 20\mu\text{s})$

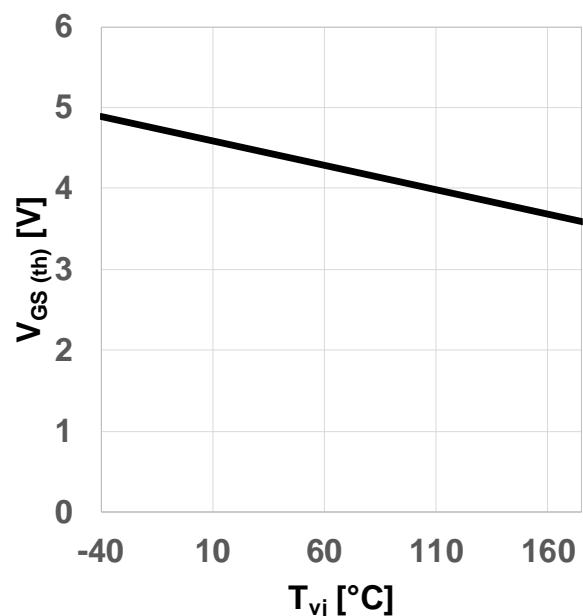


Figure 6 Typical gate-source threshold voltage
as a function of junction temperature
 $(V_{GS(th)} = f(T_{vj}), I_{DS} = 5.6\text{mA}, V_{GS} = V_{DS})$

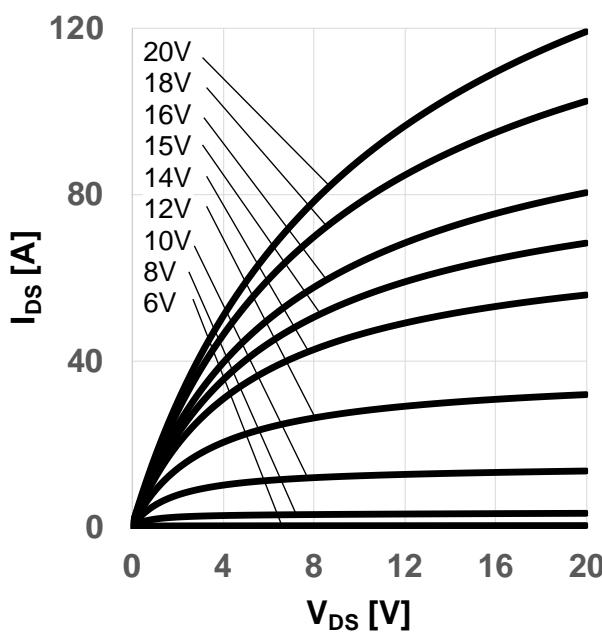


Figure 7 Typical output characteristic, V_{GS} as parameter
 $(I_{DS} = f(V_{DS}), T_{vj}=25^\circ\text{C}, t_p = 20\mu\text{s})$

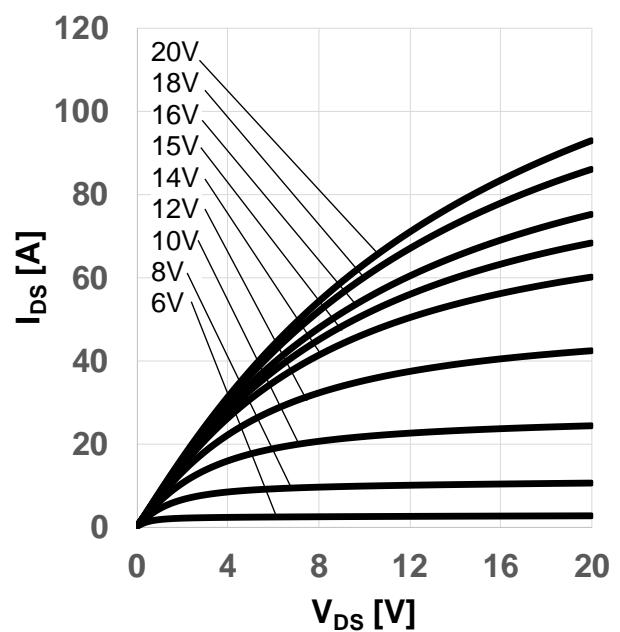


Figure 8 Typical output characteristic, V_{GS} as parameter
 $(I_{DS} = f(V_{DS}), T_{vj}=175^\circ\text{C}, t_p = 20\mu\text{s})$

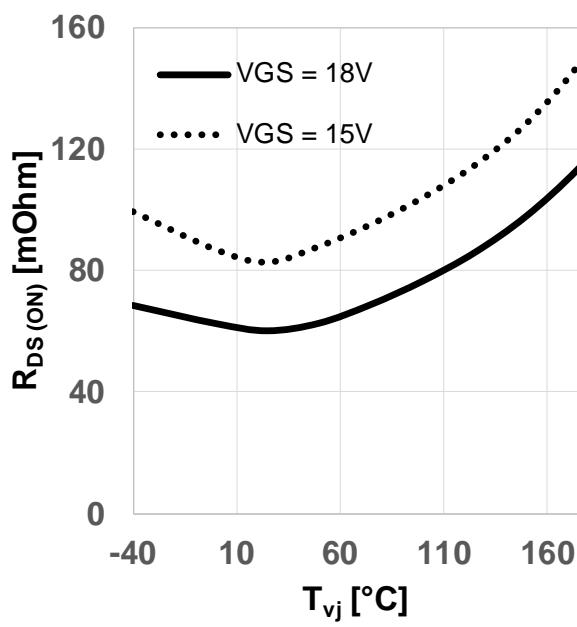


Figure 9 Typical on-resistance as a function of junction temperature
($R_{DS(on)} = f(T_{vj})$, $I_{DS} = 13A$)

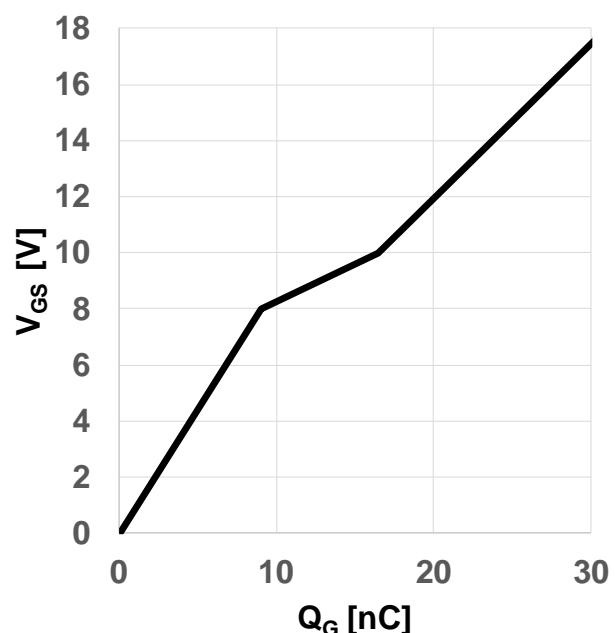


Figure 10 Typical gate charge
($V_{GS} = f(Q_G)$, $I_{DS} = 13A$, $V_{DS} = 800V$, turn-on pulse)

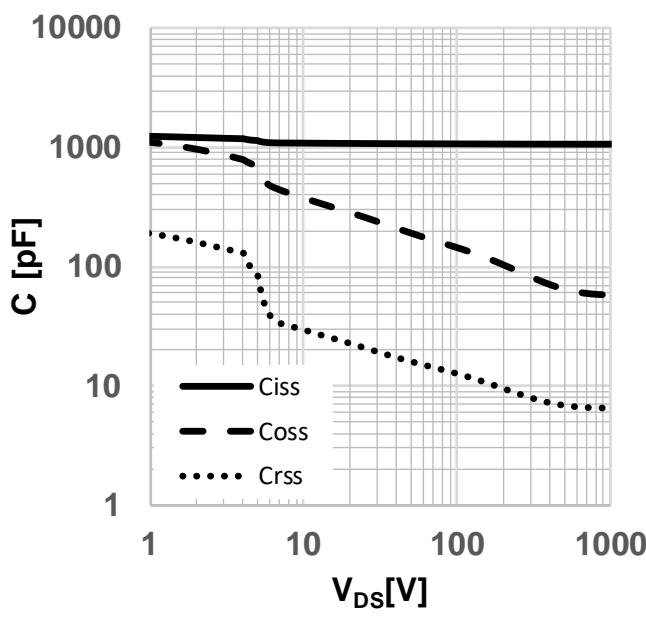


Figure 11 Typical capacitance as a function of drain-source voltage
($C = f(V_{DS})$, $V_{GS} = 0V$, $f = 1MHz$)

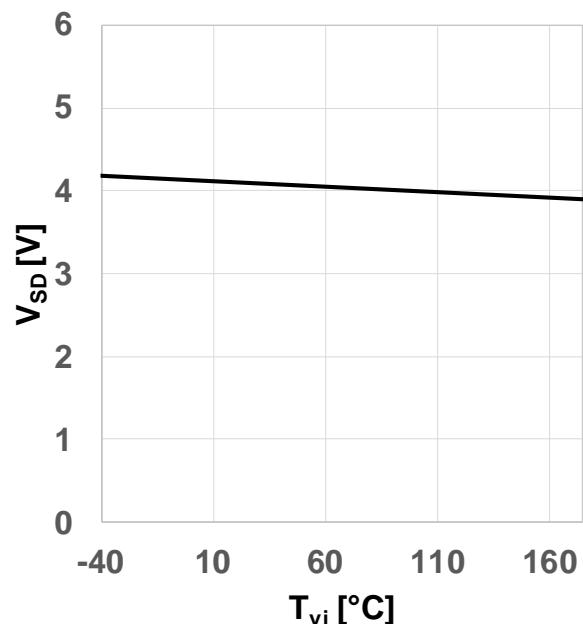


Figure 12 Typical body diode forward voltage as function of junction temperature
($V_{SD} = f(T_{vj})$, $V_{GS} = 0V$, $I_{SD} = 13A$)

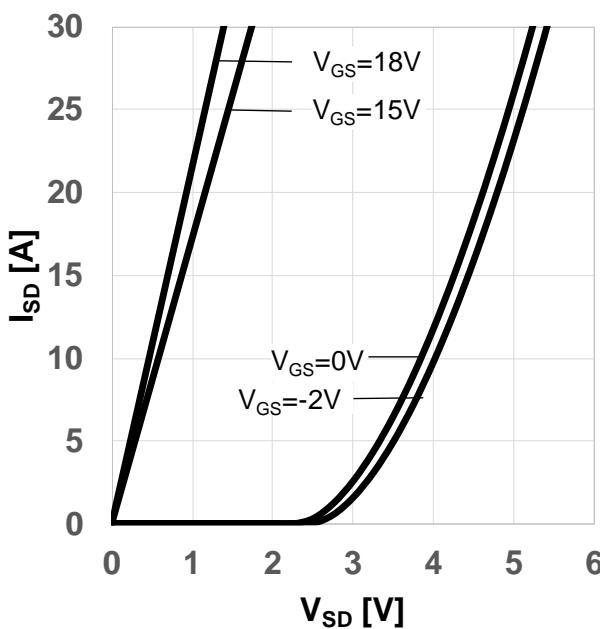


Figure 13 Typical body diode forward current as function of forward voltage, V_{GS} as parameter
 $(I_{SD} = f(V_{SD}), T_{vj} = 25^{\circ}\text{C}, t_p = 20\mu\text{s})$

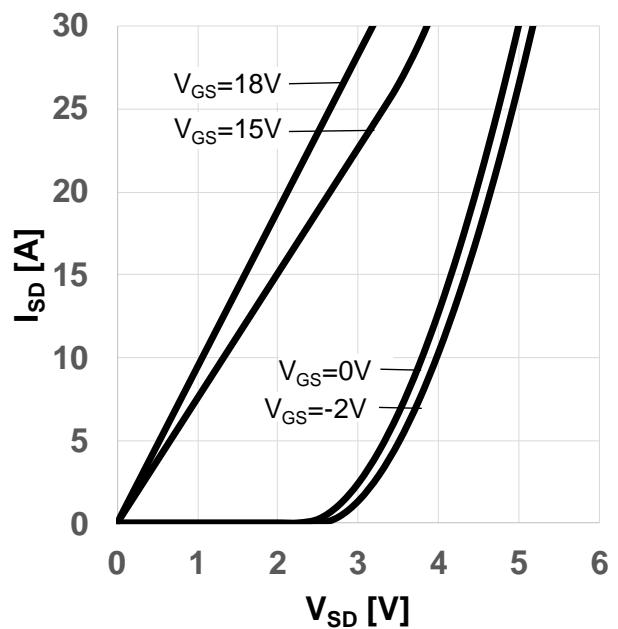


Figure 14 Typical body diode forward current as function of forward voltage, V_{GS} as parameter
 $(I_{SD} = f(V_{SD}), T_{vj} = 175^{\circ}\text{C}, t_p = 20\mu\text{s})$

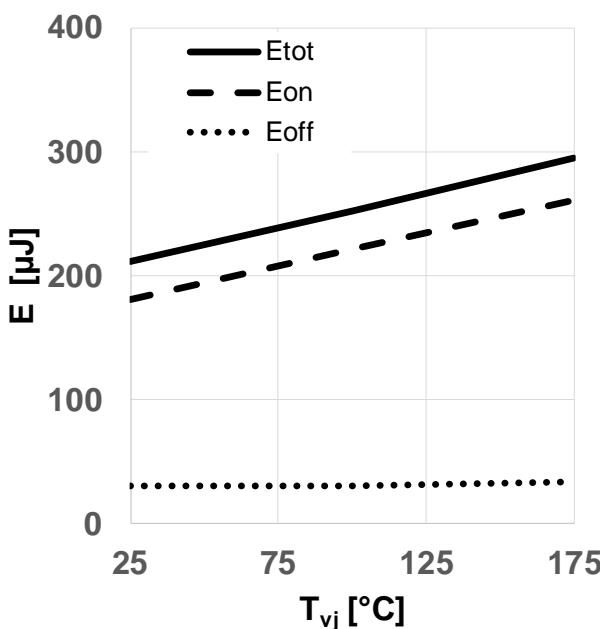


Figure 15 Typical switching energy losses as a function of junction temperature
 $(E = f(T_{vj}), V_{DD} = 800V, V_{GS} = 0V/18V,$
 $R_{G,\text{ext}} = 2\Omega, I_D = 13A$, ind. load, test circuit
in Fig. E, diode: body diode at $V_{GS} = 0V$)

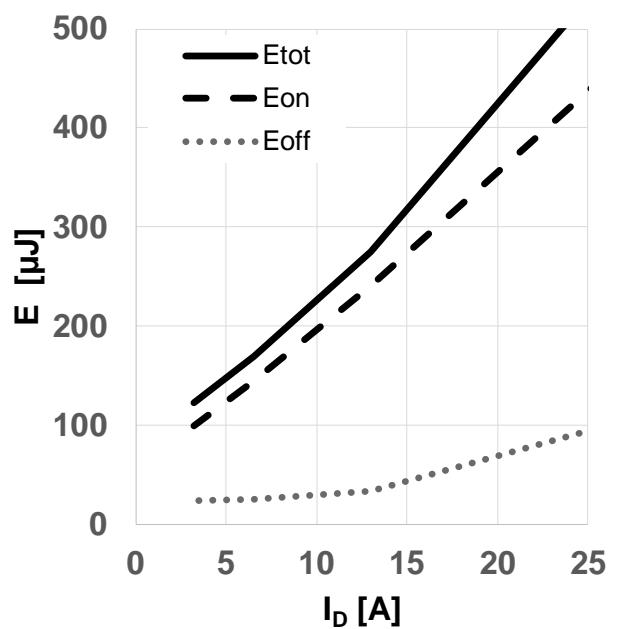


Figure 16 Typical switching energy losses as a function of drain-source current
 $(E = f(I_{DS}), V_{DD} = 800V, V_{GS} = 0V/18V,$
 $R_{G,\text{ext}} = 2\Omega, T_{vj} = 175^{\circ}\text{C}$, ind. load, test
circuit in Fig. E, diode: body diode at $V_{GS} = 0V$)

Electrical characteristic diagrams

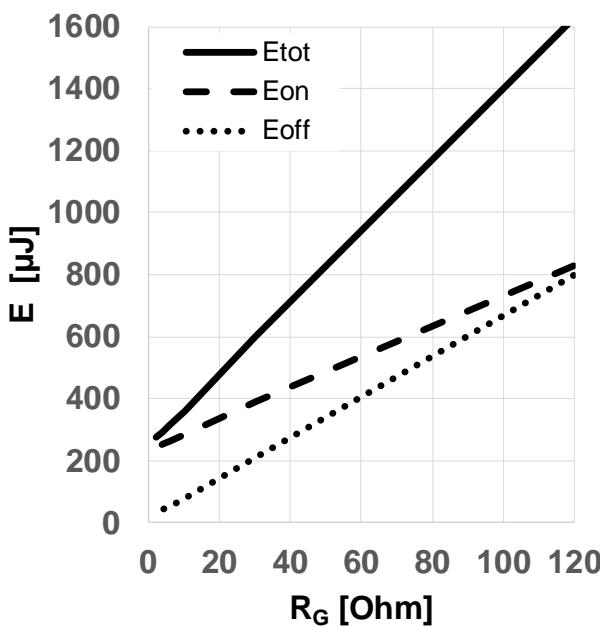


Figure 17 Typical switching energy losses as a function of gate resistance
 $(E = f(R_{G,\text{ext}}), V_{DD} = 800\text{V}, V_{GS} = 0\text{V}/18\text{V}, I_D = 13\text{A}, T_{vj} = 175^\circ\text{C, ind. load, test circuit in Fig. E, diode: body diode at } V_{GS} = 0\text{V})$

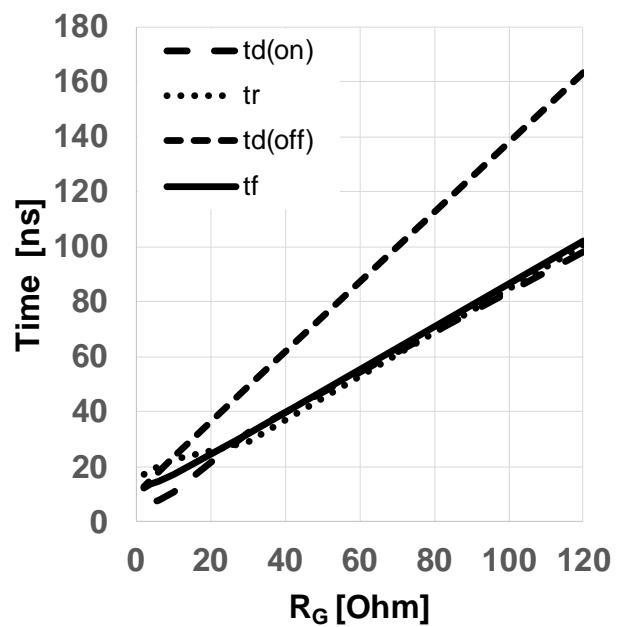


Figure 18 Typical switching times as a function of gate resistor
 $(t = f(R_{G,\text{ext}}), V_{DD} = 800\text{V}, V_{GS} = 0\text{V}/18\text{V}, I_D = 13\text{A}, T_{vj} = 175^\circ\text{C, ind. load, test circuit in Fig. E, diode: body diode at } V_{GS} = 0\text{V})$

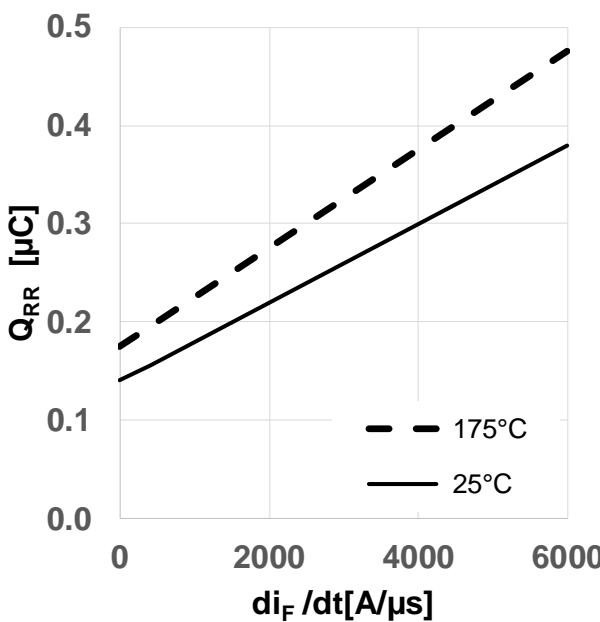


Figure 19 Typical reverse recovery charge as a function of diode current slope
 $(Q_{rr} = f(di_f/dt), V_{DD} = 800\text{V}, V_{GS} = 0\text{V}/18\text{V}, I_D = 13\text{A, ind. load, test circuit in Fig. E, body diode at } V_{GS} = 0\text{V})$

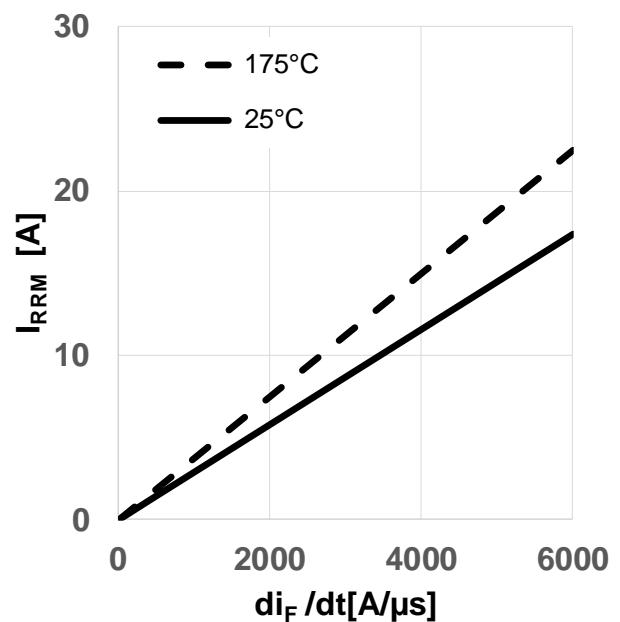


Figure 20 Typical reverse recovery current as a function of diode current slope
 $(I_{rrm} = f(di_f/dt), V_{DD} = 800\text{V}, V_{GS} = 0\text{V}/18\text{V}, I_D = 13\text{A, ind. load, test circuit in Fig. E, body diode at } V_{GS} = 0\text{V})$

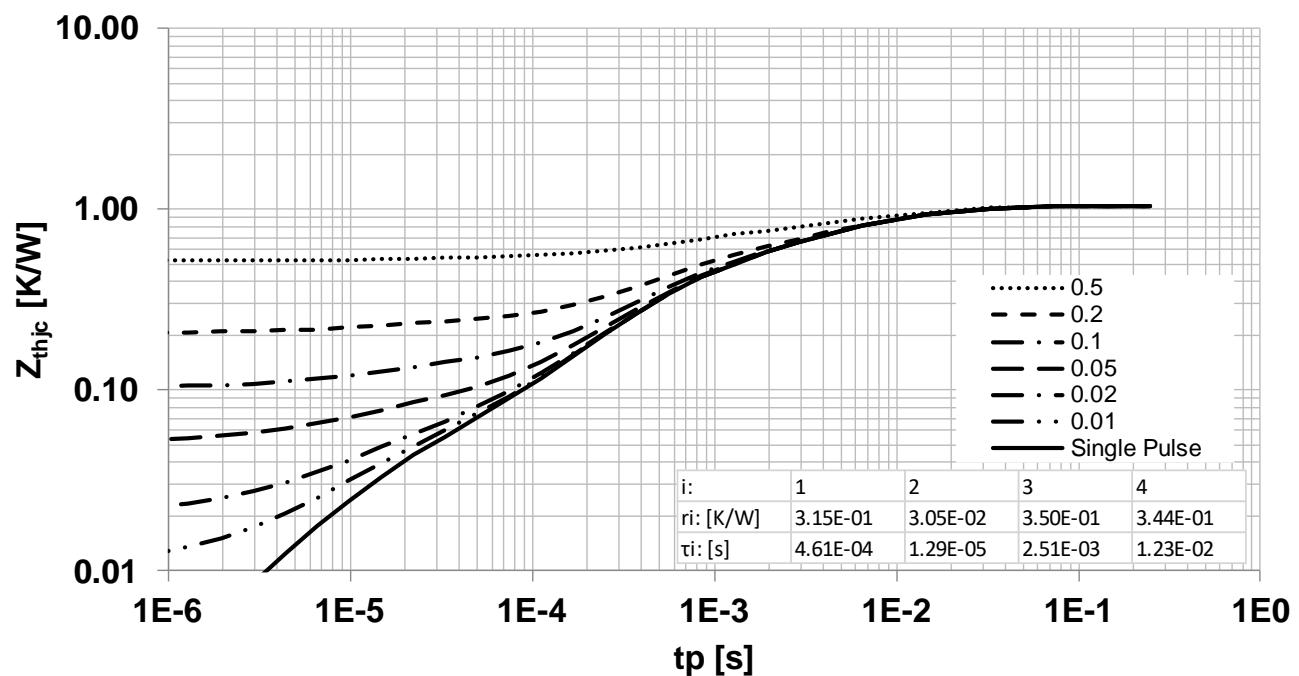
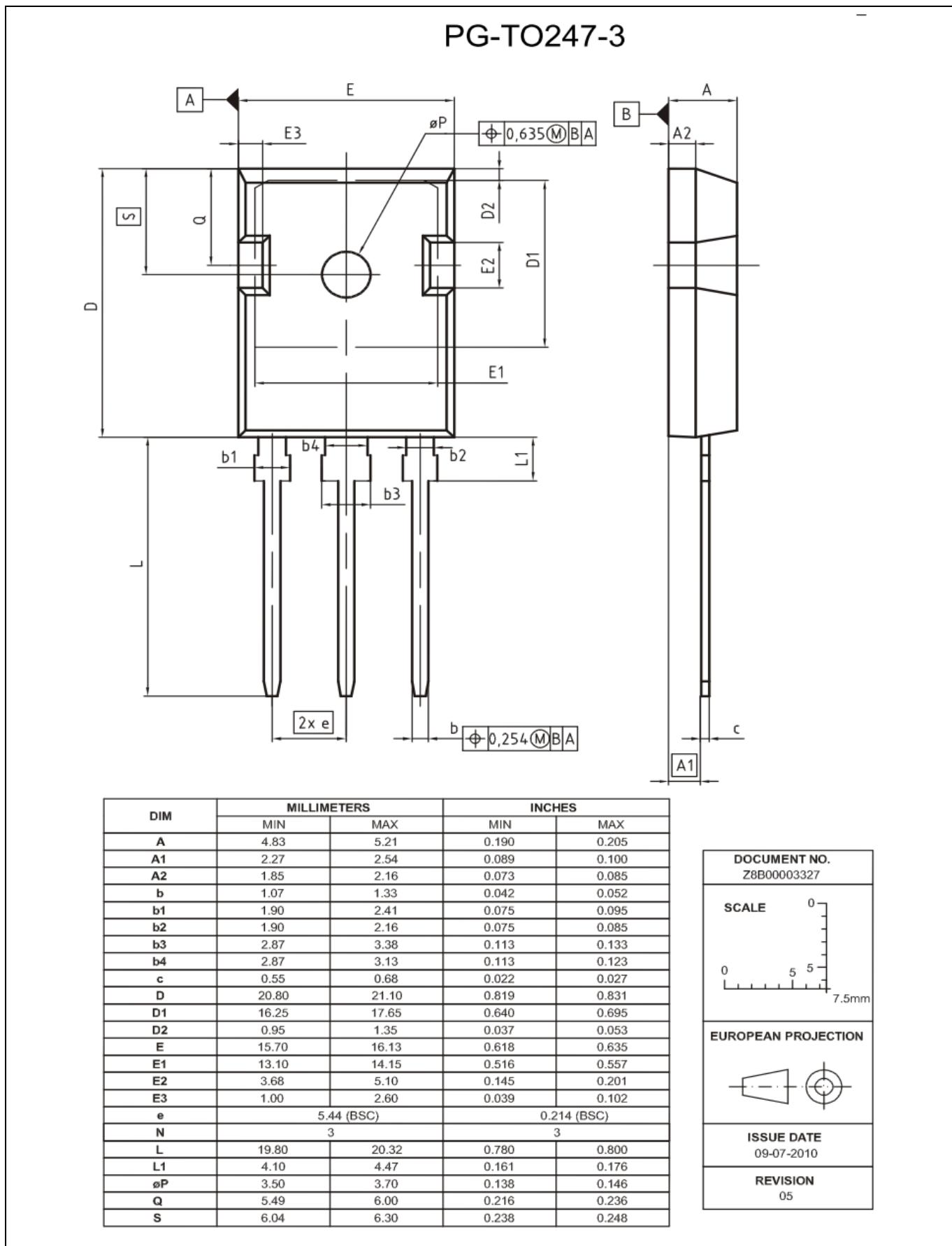


Figure 21 Max. transient thermal resistance (MOSFET/diode)

$(Z_{th(jc,max)} = f(t_p))$, parameter $D = t_p/T$, thermal equivalent circuit in Fig. D)

Package drawing

5 Package drawing

**Figure 22 Package drawing**

Test conditions

6 Test conditions

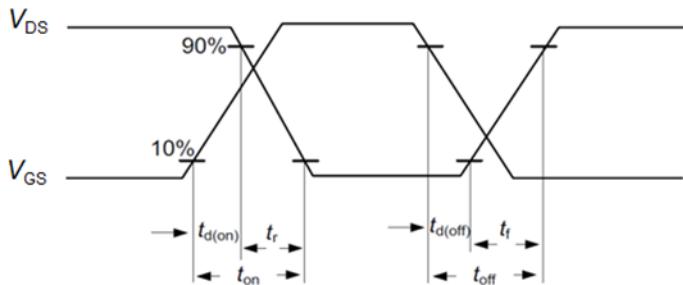


Figure A. Definition of switching times

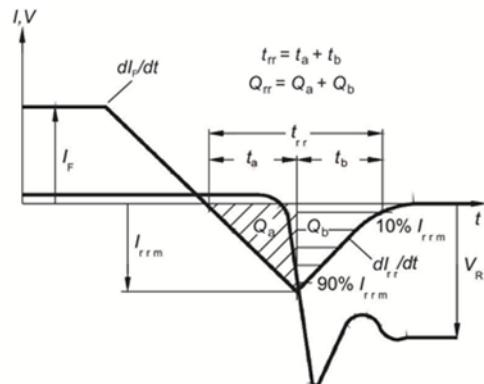


Figure C. Definition of diode switching characteristics

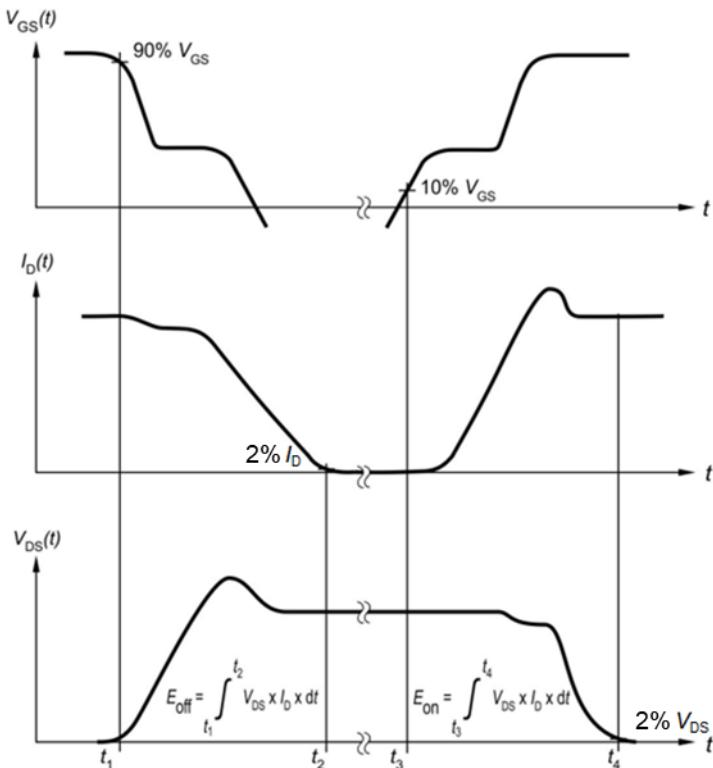


Figure B. Definition of switching losses

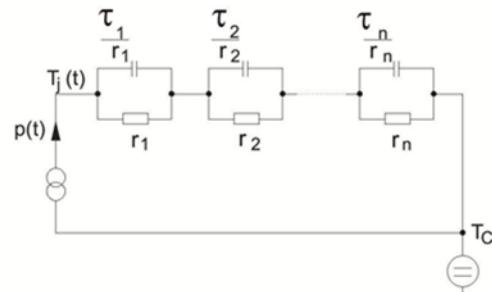


Figure D. Thermal equivalent circuit

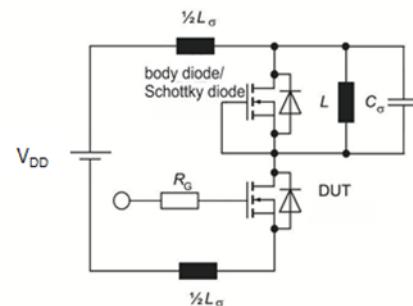


Figure E. Dynamic test circuit

Parasitic inductance L_σ ,
parasitic capacitor C_σ ,

Figure 23 Test conditions

Revision history

Document version	Date of release	Description of changes
2.0	2019-08-22	Final Datasheet
2.1	2019-12-10	<ul style="list-style-type: none">• Move the short circuit time from dynamic characteristics table 5 to maximum ratings table 2.• Update the Figure 12, 13, 14 the body diode forward voltage.
2.2	2020-12-11	Correction of circuit symbol on page 1

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